



ELECTRONICS, INC.
44 FARRAND STREET
BLOOMFIELD, NJ 07003
(973) 748-5089
<http://www.nteinc.com>

NTE3089
Optoisolator
AC Input, Silicon NPN
Phototransistor Output

Description:

The NTE3089 consists of two gallium arsenide LEDs connected in inverse parallel and coupled with a silicon phototransistor in a 6-Lead DIP type package.

Features:

- AC or Polarity Insensitive Inputs
- Fast Switching Speeds
- Built-In Reverse Polarity Input Protection
- High Isolation Voltage
- High Isolation Resistance
- I/O Compatible with Integrated Circuits

Absolute Maximum Ratings: ($T_A = +25^\circ\text{C}$, unless otherwise specified)

Infrared Emitting Diode (LED)

| | |
|--|-----------|
| Continuous Forward Current, I_F | 60mA |
| Peak Forward Current (Pulse Width = 1μs, 330pps), I_F | ±1A |
| Power Dissipation ($T_A = +25^\circ\text{C}$, Note 1), P_D | 100mW |
| Derate Above 25°C | 1.33mW/°C |

Phototransistor

| | |
|--|----------|
| Collector-Emitter Voltage, V_{CEO} | 30V |
| Collector-Base Voltage, V_{CBO} | 70V |
| Emitter-Base Voltage, V_{EBO} | 5V |
| Continuous Collector Current, I_C | 100mA |
| Power Dissipation ($T_A = +25^\circ\text{C}$), P_D | 300mW |
| Derate Above 25°C | 4.0mW/°C |
| Power Dissipation ($T_A = +25^\circ\text{C}$, Note 1), P_D | 500mW |
| Derate Above 25°C | 6.7mW/°C |

Total Device

Steady-State Isolation Voltage (Input-to-Output)

| | |
|------------|-------|
| Peak | 1500V |
| RMS | 1060V |

Surge Isolation Voltage (Input-to-Output)

| | |
|------------|-------|
| Peak | 2500V |
| RMS | 1770V |

Operating Temperature Range, T_J

-55° to +150°C

Storage Temperature Range, T_{stg}

-55° to +150°C

Lead Temperature (During Soldering for 10sec), T_L

+250°C

Note 1. T_C indicates Collector lead temperature 1/32" from case.

Electrical Characteristics: ($T_A = +25^\circ\text{C}$ unless otherwise specified)

| Parameter | Symbol | Test Conditions | Min | Typ | Max | Unit |
|--------------------------------------|-----------------------------|---|-----|-----|-----|------|
| Infrared Emitting Diode (LED) | | | | | | |
| Forward Voltage | V_F | $I_F = \pm 10\text{mA}$ | - | - | 1.5 | V |
| Capacitance | C_J | $V_R = 0, f = 1\text{MHz}$ | - | - | 100 | pF |
| Phototransistor | | | | | | |
| Collector-Base Breakdown Voltage | $V_{(\text{BR})\text{CBO}}$ | $I_C = 100\mu\text{A}, I_F = 0$ | 70 | - | - | V |
| Collector-Emitter Breakdown Voltage | $V_{(\text{BR})\text{CEO}}$ | $I_C = 10\text{mA}, I_F = 0$ | 30 | - | - | V |
| Emitter-Base Breakdown Voltage | $V_{(\text{BR})\text{EBO}}$ | $I_E = 100\mu\text{A}, I_F = 0$ | 5 | - | - | V |
| Collector Dark Current | I_{CEO} | $V_{\text{CE}} = 10\text{V}, I_F = 0$ | - | - | 100 | nA |
| Coupled | | | | | | |
| DC Current Transfer Ratio | CTR | $V_{\text{CE}} = 10\text{V}, I_F = \pm 10\text{mA}$ | 20 | - | - | % |
| Collector-Emitter Saturation Voltage | $V_{\text{CE}(\text{sat})}$ | $I_C = 0.5\text{mA}, I_F = \pm 10\text{mA}$ | - | - | 0.4 | V |
| Isolation Resistance | $R_{(\text{I}-\text{O})}$ | $V_{(\text{I}-\text{O})} = 500\text{V}$, Note 2 | 100 | - | - | GΩ |

Note 2. Tests of Input-to-Output isolation current resistance, and capacitance are performed with the input terminals (diode) shorted together and the output terminals (transistors) shorted together.

